

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Lawrence Pileggi)	
)	
Application No.: 10/707,205)	Group Art Unit: 2138
)	
)	Examiner: Saqib Javaid Siddiqui
)	
Filed: November 26, 2003)	Confirmation No.: 1204
)	
Title: SYSTEM AND METHOD TO)	
TEST INTEGRATED CIRCUITS)	
ON A WAFER)	
)	

Mail Stop: AF
Commissioner for Patents
PO Box 1450
Alexandria, VA 22313-1450

AMENDMENT AFTER FINAL ACTION UNDER 37 CFR §1.116

Sir:

In response to the Office Action dated as mailed August 22, 2006, please amend the above-identified application as follows:

There are no Amendments to the Specification.

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 15 of this paper.

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